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FCC RF Exposure Report

Report Number: M160508-3 Rev 1.0

Test Sample: Card Processor

Model Number: CP6100

FCC ID 2AIKG-CP6100

Tested For: Vix Technology

Date of Issue: 20 September 2016

EMC Technologies Pty Ltd reports apply only to the specific samples tested under stated test conditions. It is the manufacturer's responsibility to assure that additional production units of this model are manufactured with identical electrical and mechanical components. EMC Technologies Pty Ltd shall have no liability for any deductions, inferences or generalisations drawn by the client or others from EMC Technologies Pty Ltd issued reports. This report shall not be used to claim, constitute or imply product endorsement by EMC Technologies Pty Ltd.



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FCC RF Exposure Evaluation Report

Report Number: M160508-3 REV 1.0

Test Sample: Card Processor

Model Number: CP6100

Serial Number: Not marked

Manufacturer: Vix Technology

FCC ID: 2AIKG-CP6100

Tested for: Vix Technology

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Test Standard/s: FCC KDB 447498 D01 General RF Exposure Guidance v6

Mobile and Portable Devices RF Exposure Procedures and

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Equipment Authorization Policies.

FCC Title 47, Part 2.1091, Part 1.1310

Result of Test: Card Processor model CP6100 complies with the requirement

of KDB 447498 D01 and with FCC Title 47, Part 2.1091, Part

1.1310

Test Date: 20 September 2016

Test Engineer: Emad Mansour

EMC/EMR/SAR Engineer M.Sc. in Telecommunication

Authorised Signature:

Chris Zombolas Technical Director

EMC Technologies Pty Ltd

1 INTRODUCTION

This report shows the Maximum permissible exposure (MPE) on Card Processor model CP6100, in accordance with the Federal Communications Commission (FCC) regulations as detailed in KDB 447498 D01,

The test sample was provided by the Client. The conclusion herein is based on the information provided by the client.

2 EXPOSURE EVALUATION FOR MOBILE DEVICE

A mobile device is defined as a transmitting device designed to be used in other than fixed locations and to generally be used in such a way that a separation distance of at least 20 centimeters is normally maintained between the transmitter's radiating structure(s) and the body of the user or nearby persons.

Radio frequency radiation exposure evaluation for mobile devices as defined by (47 CFR §2.1091).

3 GENERAL INFORMATION

(Information supplied by the Client)

The Equipment Under Test (EUT) was identified as follows:

Test Sample: Card Processor Model Number: CP6100
Manufacturer: Vix Technology

Radio Module: Contactless Card Reader

Operating frequency (MHz): 13.56 EIRP* 13.56

WLAN Module:

FCC ID VZFSWN26MA
Operating frequency (MHz): 2412 – 2462
Output Power 35 mW
Antenna Model FXP70
Antenna Gain 5 dBi

Bluetooth dongle:

FCC ID QOQBLED112 Max. E.I.R.P 1.11 mW Operating frequency (MHz): 2402 – 2480

Wireless Module:

FCC ID QIPPLS8-US
Model PLS8-US
Antenna Model FXUB63
Antenna Gain 5 dBi

*For EIRP value refers to test report M160508-1 issued by EMC Technologies, field strength measured at 10m was 72.13 dB μ V/m.



4 TEST SAMPLE DESCRIPTION and TEST SETUP DETAILS

(Information supplied by the Client)

The device was intended to be used by Transport operators for fare collection. The device is typically installed inside the transport vehicle for use by passengers to tag ON and tag OFF with their travel card.

5 MAXIMUM PERMISSIBLE EXPOSURE (MPE) LIMITS

The criteria listed in table 1 shall be used to evaluate the environmental impact of human exposure to radiofrequency (RF) radiation

Table 1:

Table 1.										
Frequency range(MHz)	Electric field strength(V/m)	Magnetic field strength(A/m)	Power density(mW/cm²)	Averaging time(minutes)						
A) Limits for Occupational/Controlled Exposures										
0.3-3.0	614	1.63	*(100)	6						
3.0-30	1842/f	4.89/f	*(900/f ²)	6						
30-300	61.4	0.163	1	6						
300-1500			f/300	6						
1500-100,000			5	6						
(B) Limits for General Population/Uncontrolled Exposure										
0.3-1.34	614	1.63	*(100)	30						
1.34-30	824/f	2.19/f	*(180/ <i>f</i> ²)	30						
30-300	27.5	0.073	0.2	30						
300-1500			f/1500	30						
1500-100,000			1	30						

f = frequency in MHz



^{* =} Plane-wave equivalent power density

6 RF EXPOSURE EVALUATION

The MPE was evaluated at 25 cm to show compliance with the power density listed in table 1, as the power density at 20 cm exceeds the limit.

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The following formula was used to calculate the power density at 20 cm and 25 cm

$$S = \frac{P * G}{4\pi R^2}$$

$$S = \frac{EIRP}{4\pi R^2}$$

Where

(S): Power density (mW/cm^2)

(P): Output power at antenna terminal (mW)

(G): Gain (ratio)

(R): Minimum test separation distance (20 cm)

Table 2: Evaluation at 20 cm for the cellular Wireless Module

Technology	Frequency Band	Power	Manufacture tolerance	Gain	EIRP	EIRP	Duty Cycle	Flux Density at 20 cm	Flux Density limit	
	MHz	dBm	dB	dBi	dBm	(mW)	%	mW/cm ²	mW/cm ²	(%)
LTE 700	706.5	23	0.5	5	28.5	707.95	100.00	0.1409	0.471	29.92%
LTE 850	824.7	23	0.5	5	28.5	707.95	100.00	0.1409	0.55	25.62%
LTE 1700	1719.7	23	0.5	5	28.5	707.95	100.00	0.1409	1.00	14.09%
LTE 1900	1850.7	23	0.5	5	28.5	707.95	100.00	0.1409	1.00	14.09%
UMTS 850	826.4	24	0.5	5	29.5	891.25	100.00	0.1774	0.551	32.20%
UMTS 1700	1712.4	24	0.5	5	29.5	891.25	100.00	0.1774	1.00	17.74%
UMTS 1900	1852.4	24	0.5	5	29.5	891.25	100.00	0.1774	1.00	17.74%
GSM 850	824.2	33	0.5	5	38.5	7079.46	50.00	0.7046	0.549	128.34%
GSM 1900	1850.2	30	0.5	5	35.5	3548.13	50.00	0.3531	1.00	35.31%

Table 3: Evaluation at 25 cm for the cellular Wireless Module

Technology	Frequency Band	Power	Manufacture tolerance	Gain	EIRP	EIRP	Duty Cycle	Flux Density at 20 cm	Flux Density limit	
	MHz	dBm	dB	dBi	dBm	(mW)	%	mW/cm ²	mW/cm ²	(%)
LTE 700	706.5	23	0.5	5	28.5	707.95	100.00	0.0902	0.471	19.15%
LTE 850	824.7	23	0.5	5	28.5	707.95	100.00	0.0902	0.55	16.40%
LTE 1700	1719.7	23	0.5	5	28.5	707.95	100.00	0.0902	1.00	9.02%
LTE 1900	1850.7	23	0.5	5	28.5	707.95	100.00	0.0902	1.00	9.02%
UMTS 850	826.4	24	0.5	5	29.5	891.25	100.00	0.1135	0.551	20.61%
UMTS 1700	1712.4	24	0.5	5	29.5	891.25	100.00	0.1135	1.00	11.35%
UMTS 1900	1852.4	24	0.5	5	29.5	891.25	100.00	0.1135	1.00	11.35%
GSM 850	824.2	33	0.5	5	38.5	7079.46	50.00	0.4509	0.549	82.13%
GSM 1900	1850.2	30	0.5	5	35.5	3548.13	50.00	0.2260	1.00	22.60%

Table 4: Simulations transmission evaluation at 25 cm

Technology	Frequency Band	Power	Manufacture tolerance	Gain	EIRP	EIRP	Duty Cycle	Flux Density at 20 cm	Flux Density limit	
	MHz	dBm	dB	dBi	dBm	(mW)	%	mW/ cm ²	mW/cm ²	(%)
cardless	13.56	-	-	ı	ı	0.054	100	0.0069	0.979	0.70%
WLAN	2450	15	-	5	20	100.00	100	0.0127	1.00	1.27%
GSM 850	824.2	33	0.5	5	38.5	7079.46	50	0.4509	0.549	82.13%
ВТ	2450	-	-	-	0.45	1.11	100	0.0001	1.00	0.01%
Total percentage of the limit at 25 cm										

*worst case from the cellular wireless module used for simulations transmission evaluation. The percentage of the limit for all the power densities at 25 cm is 84.12% of the general public limit.

7 CONCLUSION

Card Processor model CP6100 complies with the requirement of KDB 447498 D01 and with FCC Title 47, Part 2.1091 and Part 1.1310 in mobile exposure condition for a separation distance of more than 25 cm.

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